

# MOSFET - Power, Single N-Channel 80 V, 1.9 m $\Omega$ , 224 A

## **NVMFS6H800NL**

#### **Features**

- Small Footprint (5x6 mm) for Compact Design
- Low R<sub>DS(on)</sub> to Minimize Conduction Losses
- Low Q<sub>G</sub> and Capacitance to Minimize Driver Losses
- NVMFS6H800NLWF Wettable Flank Option for Enhanced Optical Inspection
- AEC-Q101 Qualified and PPAP Capable
- These Devices are Pb-Free and are RoHS Compliant

#### **MAXIMUM RATINGS** (T<sub>J</sub> = 25°C unless otherwise noted)

Parar	Symbol	Value	Unit		
Drain-to-Source Voltage			$V_{DSS}$	80	V
Gate-to-Source Voltage	Э		V <sub>GS</sub>	±20	V
Continuous Drain	Steady State	T <sub>C</sub> = 25°C	I <sub>D</sub>	224	Α
Current R <sub>θJC</sub> (Notes 1, 3)	State	T <sub>C</sub> = 100°C		158	
Power Dissipation		T <sub>C</sub> = 25°C	$P_{D}$	214	W
R <sub>θJC</sub> (Note 1)		T <sub>C</sub> = 100°C		107	
Continuous Drain	Steady State	T <sub>A</sub> = 25°C	I <sub>D</sub>	30	Α
Current R <sub>θJA</sub> (Notes 1, 2, 3)	State	T <sub>A</sub> = 100°C		21	
Power Dissipation		T <sub>A</sub> = 25°C	$P_{D}$	3.9	W
R <sub>θJA</sub> (Notes 1, 2)		T <sub>A</sub> = 100°C		1.9	
Pulsed Drain Current	$T_A = 25$	°C, t <sub>p</sub> = 10 µs	I <sub>DM</sub>	900	Α
Operating Junction and Storage Temperature Range			T <sub>J</sub> , T <sub>stg</sub>	-55 to +175	°C
Source Current (Body Diode)			Is	179	Α
Single Pulse Drain-to-Source Avalanche Energy (I <sub>L(pk)</sub> = 16.2 A)			E <sub>AS</sub>	601	mJ
Lead Temperature for Soldering Purposes (1/8" from case for 10 s)			TL	260	°C

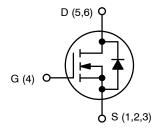
Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected.

#### THERMAL RESISTANCE MAXIMUM RATINGS

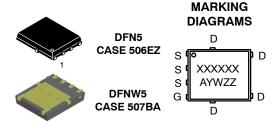
Parameter	Symbol	Value	Unit
Junction-to-Case - Steady State	$R_{\theta JC}$	0.7	°C/W
Junction-to-Ambient - Steady State (Note 2)	$R_{\theta JA}$	39	

- The entire application environment impacts the thermal resistance values shown, they are not constants and are only valid for the particular conditions noted.
- 2. Surface-mounted on FR4 board using a 650 mm<sup>2</sup>, 2 oz. Cu pad.
- Maximum current for pulses as long as 1 second is higher but is dependent on pulse duration and duty cycle.

V <sub>(BR)DSS</sub>	R <sub>DS(ON)</sub> MAX	I <sub>D</sub> MAX	
80 V	1.9 mΩ @ 10 V	224 A	
	2.4 mΩ @ 4.5 V	224 A	



**N-CHANNEL MOSFET** 



XXXXXX = Specific Device Code

A = Assembly Location

Y = Year
W = Work Week
ZZ = Lot Traceability

#### **ORDERING INFORMATION**

See detailed ordering, marking and shipping information in the package dimensions section on page 5 of this data sheet.

### **ELECTRICAL CHARACTERISTICS** (T<sub>J</sub> = 25°C unless otherwise specified)

Parameter	Symbol	Test Cond	ition	Min	Тур	Max	Unit
OFF CHARACTERISTICS							
Drain-to-Source Breakdown Voltage	V <sub>(BR)DSS</sub>	$V_{GS} = 0 \text{ V}, I_D = 250 \mu$	A	80			V
Drain-to-Source Breakdown Voltage Temperature Coefficient	V <sub>(BR)DSS</sub> /				36		mV/°C
Zero Gate Voltage Drain Current	I <sub>DSS</sub>	V <sub>GS</sub> = 0 V,	T <sub>J</sub> = 25 °C			10	
		V <sub>DS</sub> = 80 V	T <sub>J</sub> = 125°C			250	μΑ
Gate-to-Source Leakage Current	I <sub>GSS</sub>	V <sub>DS</sub> = 0 V, V <sub>GS</sub> = 20 V	<u> </u>			100	nA
ON CHARACTERISTICS (Note 4)							
Gate Threshold Voltage	V <sub>GS(TH)</sub>	$V_{GS} = V_{DS}, I_D = 330  \mathrm{g}$	ιA	1.2		2.0	V
Threshold Temperature Coefficient	V <sub>GS(TH)</sub> /T <sub>J</sub>				-5.1		mV/°C
Drain-to-Source On Resistance	R <sub>DS(on)</sub>	V <sub>GS</sub> = 10 V	I <sub>D</sub> = 50 A		1.5	1.9	mΩ
		V <sub>GS</sub> = 4.5 V	I <sub>D</sub> = 50 A		1.9	2.4	mΩ
Forward Transconductance	9FS	V <sub>DS</sub> =8 V, I <sub>D</sub> = 50 A	•		250		S
CHARGES, CAPACITANCES & GATE RESI	STANCE						
Input Capacitance	C <sub>ISS</sub>	V <sub>GS</sub> = 0 V, f = 1 MHz, V <sub>DS</sub> = 40 V			6900		pF
Output Capacitance	C <sub>OSS</sub>				800		1
Reverse Transfer Capacitance	C <sub>RSS</sub>	1			22		
Total Gate Charge	Q <sub>G(TOT)</sub>	V <sub>GS</sub> = 10 V, V <sub>DS</sub> = 40 V; I <sub>D</sub> = 50 A			112		nC
Threshold Gate Charge	Q <sub>G(TH)</sub>	V <sub>GS</sub> = 4.5 V, V <sub>DS</sub> = 40 V; I <sub>D</sub> = 50 A			10		1
Gate-to-Source Charge	Q <sub>GS</sub>	1			19		
Gate-to-Drain Charge	$Q_{GD}$	1			17		1
Plateau Voltage	$V_{GP}$				3.0		V
Total Gate Charge	Q <sub>G(TOT)</sub>	1			53		nC
SWITCHING CHARACTERISTICS (Note 5)	•	•		•		•	•
Turn-On Delay Time	t <sub>d(ON)</sub>	$V_{GS} = 4.5 \text{ V}, V_{DS} = 64.5 \text{ V}$	4 V,		20		ns
Rise Time	t <sub>r</sub>	$I_D = 50 \text{ A}, R_G = 2.5 \Omega$			153		-
Turn-Off Delay Time	t <sub>d(OFF)</sub>	1			118		
Fall Time	t <sub>f</sub>	1			163		1
DRAIN-SOURCE DIODE CHARACTERISTI	cs	•		•		•	•
Forward Diode Voltage	$V_{SD}$	V <sub>GS</sub> = 0 V,	T <sub>J</sub> = 25°C		0.8	1.2	V
		$I_S = 50 \text{ A}$ $T_J = 125^{\circ}\text{C}$	T <sub>J</sub> = 125°C		0.7		1
Reverse Recovery Time	t <sub>RR</sub>	$V_{GS} = 0 \text{ V}, \text{ dIS/dt} = 10$	00 A/μs,	1	77	1	ns
Charge Time	t <sub>a</sub>	I <sub>S</sub> = 50 A			40		1
Discharge Time	t <sub>b</sub>				38		1
Reverse Recovery Charge	Q <sub>RR</sub>				110	1	nC
Product parametric performance is indicated i		Characteristics for the	licted test condi	tions unl	occ other	wice note	d Drod

Product parametric performance is indicated in the Electrical Characteristics for the listed test conditions, unless otherwise noted. Product performance may not be indicated by the Electrical Characteristics if operated under different conditions.

4. Pulse Test: pulse width ≤ 300 μs, duty cycle ≤ 2%.

5. Switching characteristics are independent of operating junction temperatures.

#### **TYPICAL CHARACTERISTICS**

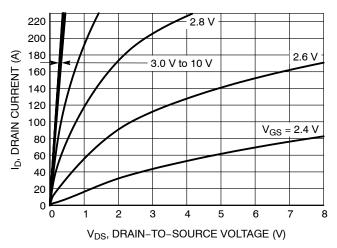


Figure 1. On-Region Characteristics

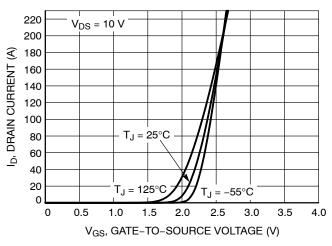


Figure 2. Transfer Characteristics

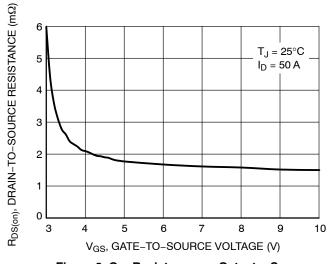


Figure 3. On-Resistance vs. Gate-to-Source Voltage

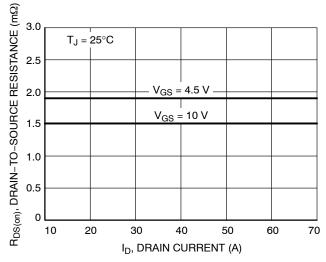


Figure 4. On-Resistance vs. Drain Current and Gate Voltage

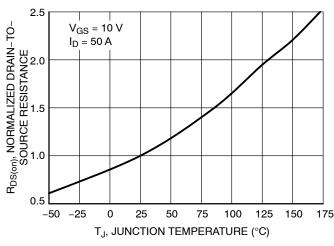


Figure 5. On–Resistance Variation with Temperature

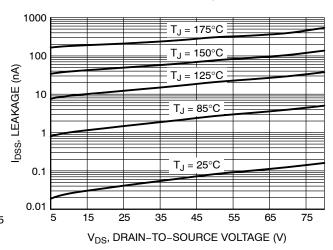


Figure 6. Drain-to-Source Leakage Current vs. Voltage

#### TYPICAL CHARACTERISTICS (continued)

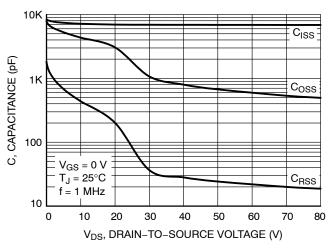


Figure 7. Capacitance Variation

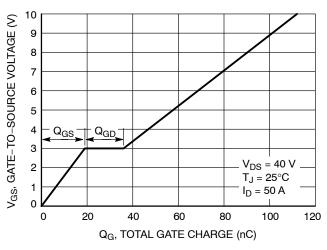


Figure 8. Gate-to-Source vs. Total Charge

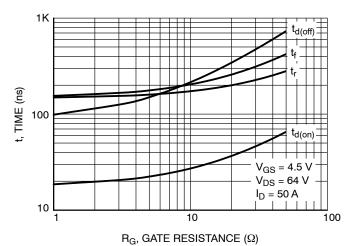


Figure 9. Resistive Switching Time Variation vs. Gate Resistance

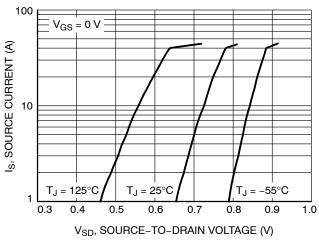


Figure 10. Diode Forward Voltage vs. Current

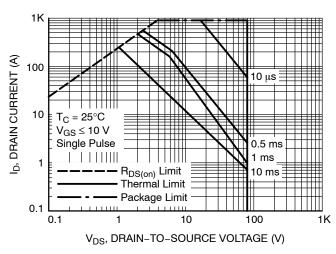


Figure 11. Maximum Rated Forward Biased Safe Operating Area

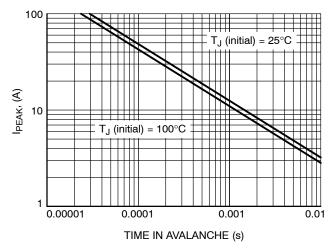


Figure 12. Maximum Drain Current vs. Time in Avalanche

#### TYPICAL CHARACTERISTICS (continued)

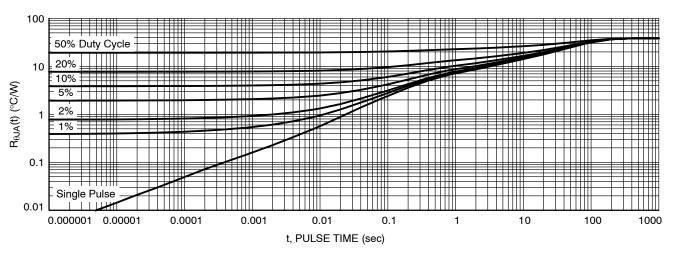


Figure 13. Thermal Response

#### **DEVICE ORDERING INFORMATION**

Device	Case	Marking	Package	Shipping <sup>†</sup>
NVMFS6H800NLT1G	506EZ	6H800L	DFN5 (Pb-Free)	1500 / Tape & Reel
NVMFS6H800NLWFT1G	507BA	800LWF	DFNW5 (Pb-Free, Wettable Flanks)	1500 / Tape & Reel

<sup>†</sup>For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specifications Brochure, <a href="https://example.com/BRD8011/D">BRD8011/D</a>.

SCALE 2:1





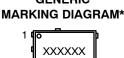
**DATE 25 AUG 2021** 

**MILLIMETERS** 

- NOTES:
  1. DIMENSIONING AND TOLERANCING PER ASME Y14.5M, 2009.
  2. CONTROLLING DIMENSION: MILLIMETERS
  3. DIMENSIONS D1 AND E1 DO NOT INCLUDE MOLD FLASH, PROTRUSIONS, OR GATE BURRS.

	d I III					
			DIM	I MIN.	N□M.	MAX.
PIN 1 IDENTIFIER —			э <b>А</b>	0.90	1.00	1.10
1	i i	i	A1	0.00		0.05
			b	0.33	0.41	0.51
٩		<u> </u>	_ c	0.23	0.28	0.33
·		A1-J I V	ם ו	5.00	5.15	5.30
	TOP VIEW		EATING D1	4.70	4.90	5.10
	101 112 11		D2	3.80	4.00	4.20
	DETAIL A —		E	6.00	6.15	6.30
// 0.10 C	$\overline{}$		E1	5.70	5.90	6.10
4		<b>‡</b>	E2	3.45	3.80	3.85
□ 0.10 C			е		1.27 BSC	,
	SIDE VIEW	SEATING C PLANE	G	0.51	0.575	0.71
	OIDL VILW		k	1.10	1.20	1.40
8X b	-		L	0.51	0.575	0.71
⊕ 0.10 C A B 0.05 C			L1		0.125 RE	F
[ * [0.05[C]	<del>   </del> e		М	3.00	3.40	3.80
	<del>    e/2</del>		θ	0*		12*
<u>1</u> 		K	2X 0.4950-	2× 1.53-	.56 <del></del>	
i 🕏	<del></del>	PACKAGE	2X 0.25-	刑	<del> </del>	

(EXPOSED PAD) **GENERIC** BOTTOM VIEW



PACKAGE DUTLINE

2X 0.91

0.97

4X 1.00

4X 0.75-



= Year

= Work Week

Α Υ

W

ZZ

= Assembly Location

RECOMMENDED MOUNTING FOOTPRINT

\_ 1.27 PITCH

For additional information on our Pb-Free strategy and soldering details, please download the IN Semiconductor Soldering and Mounting Techniques Reference Manual, SDLDERRM/D.

= Lot Traceability \*This information is generic. Please refer to device data sheet for actual part marking. Pb-Free indicator, "G" or microdot " ■" may or may not be present. Some products may not follow the Generic Marking.

DOCUMENT NUMBER:	98AON24855H	Electronic versions are uncontrolled except when accessed directly from the Document Reposit Printed versions are uncontrolled except when stamped "CONTROLLED COPY" in red.		
DESCRIPTION:	DFN5 5x6, 1.27P (SO-8FL)		PAGE 1 OF 1	

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IDENTIFIER

// 0.10 C

△|0.10|C

(EXPOSED PAD)

#### DFNW5 4.90x5.90x1.00, 1.27P CASE 507BA **ISSUE B**

A

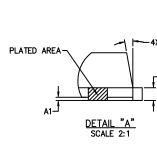
F1

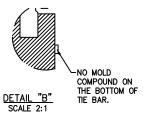
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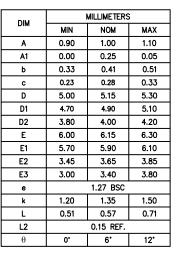
**DATE 15 JUL 2024** 

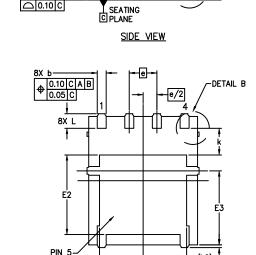


- DIMENSIONING AND TOLERANCING CONFORM TO ASME Y14.5M-2018.
- ALL DIMENSIONS ARE IN MILLIMETERS.
  DIMENSIONS D1 AND E1 D0 NOT INCLUDE MOLD FLASH,
- PROTRUSIONS, OR GATE BURRS.
  THIS PACKAGE CONTAINS WETTABLE FLANK DESIGN FEATURES TO AID IN FILLET FORMATION ON THE LEADS DURING MOUNTING.





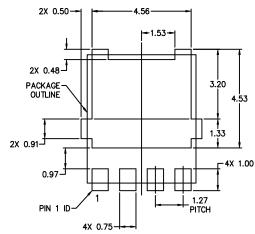




**BOTTOM VIEW** 

TOP VIEW

DETAIL A



RECOMMENDED MOUNTING FOOTPRINT\* \*FOR ADDITIONAL INFORMATION ON OUR PD-FREE STRATEGY AND SOLDERING DETAILS, PLEASE DOWNLOAD THE ONSEMI SOLDERING AND MOUNTING TECHNIQUES REFERENCE MANUAL, SOLDERRM/D.

#### **GENERIC MARKING DIAGRAM\***



XXXXXX = Specific Device Code

= Assembly Location Α

Υ = Year

W = Work Week

(L2)

ZZ = Lot Traceability \*This information is generic. Please refer to device data sheet for actual part marking. Pb-Free indicator, "G" or microdot " ■", may or may not be present. Some products may not follow the Generic Marking.

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DESCRIPTION:	DFNW5 4.90x5.90x1.00, 1.27P		PAGE 1 OF 1	

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